

**Notice of References Cited**

Application/Control No.

10/542,943

Applicant(s)/Patent Under

Reexamination

SCHOCH, EBERHARD

Examiner

ARUN WILLIAMS

Art Unit

2838

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,717,256 A	02-1998	Okumura et al.	307/66
*	B US-5,870,025 A	02-1999	Hinohara, Makoto	340/636.12
*	C US-6,236,214 B1	05-2001	Camp et al.	324/427
*	D US-6,281,683 B1	08-2001	Podrazhansky et al.	324/432
*	E US-6,316,967 B1	11-2001	Takagi et al.	327/50
*	F US-2002/0039037 A1	04-2002	Takada et al.	327/108
*	G US-6,396,725 B1	05-2002	Jacobs et al.	363/131
*	H US-2002/0060553 A1	05-2002	Kato, Kazuo	320/132
*	I US-2002/0120906 A1	08-2002	Xia et al.	716/2
*	J US-2002/0171455 A1	11-2002	Tsuchida et al.	327/108
*	K US-2004/0017180 A1	01-2004	Cook, Steven D.	320/132
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.